

Series -RoHS Compliant (Pb-free) 5.0V 4 Pad 3.2mm x 5mm Ceramic SMD HCMOS/TTL High Frequency Oscillator Frequency Tolerance/Stability ±25ppm Maximum

Operating Temperature Range -40°C to +85°C

EH35 25 ET

Pin 1 Connection Tri-State (Disabled Output: High Impedance)

- Nominal Frequency 120.000MHz

- Duty Cycle 50 ±5(%)

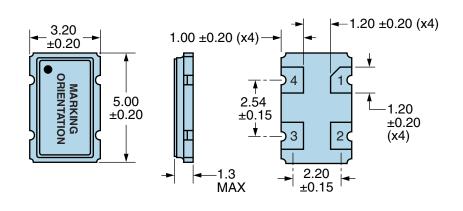
T TS -120.000M

| Nominal Frequency                     | 120.000MHz   |
|---------------------------------------|--|
| Frequency Tolerance/Stability         | ±25ppm Maximum (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, 1st Year Aging at 25°C, Shock, and Vibration) |
| Aging at 25°C                         | ±5ppm/year Maximum   |
| Operating Temperature Range           | -40°C to +85°C   |
| Supply Voltage                        | 5.0Vdc ±10%  |
| Input Current                         | 50mA Maximum (No Load)   |
| Output Voltage Logic High (Voh)       | 2.4Vdc Minimum with TTL Load, Vdd-0.4Vdc Minimum with HCMOS Load (IOH = -16mA)   |
| Output Voltage Logic Low (Vol)        | 0.4Vdc Maximum with TTL Load, 0.5Vdc Maximum with HCMOS Load (IOL = +16mA)   |
| Rise/Fall Time                        | 4nSec Maximum (Measured at 0.8Vdc to 2.0Vdc with TTL Load or at 20% to 80% of waveform with HCMOS Load)  |
| Duty Cycle                            | 50 ±5(%) (Measured at 50% of waveform with TTL Load or with HCMOS Load)  |
| Load Drive Capability                 | 5TTL Load or 15pF HCMOS Load Maximum   |
| Output Logic Type                     | CMOS   |
| Pin 1 Connection                      | Tri-State (Disabled Output: High Impedance)  |
| Tri-State Input Voltage (Vih and Vil) | +2.2Vdc Minimum to enable output, +0.8Vdc Maximum to disable output (High Impedance), No Connect to enable output.   |
| Absolute Clock Jitter                 | ±250pSec Maximum, ±100pSec Typical   |
| One Sigma Clock Period Jitter         | ±50pSec Maximum, ±30pSec Typical   |
| Start Up Time                         | 10mSec Maximum   |
| Storage Temperature Range             | -55°C to +125°C  |
|                                       |  |
| ENVIRONMENTAL & MEC                   | HANICAL SPECIFICATIONS   |
| Fine Leak Test                        | MIL-STD-883, Method 1014, Condition A  |

| Fine Leak Test               | MIL-STD-883, Method 1014, Condition A |
|------------------------------|---------------------------------------|
| Gross Leak Test              | MIL-STD-883, Method 1014, Condition C |
| Mechanical Shock             | MIL-STD-202, Method 213, Condition C  |
| Resistance to Soldering Heat | MIL-STD-202, Method 210               |
| Resistance to Solvents       | MIL-STD-202, Method 215               |
| Solderability                | MIL-STD-883, Method 2003              |
| Temperature Cycling          | MIL-STD-883, MEthod 1010              |
| Vibration                    | MIL-STD-883, Method 2007, Condition A |



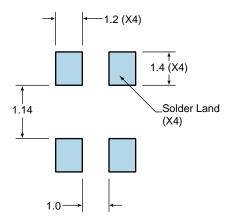
### **MECHANICAL DIMENSIONS (all dimensions in millimeters)**



| PIN  | CONNECTION                       |
|------|----------------------------------|
| 1    | Tri-State                        |
| 2    | Ground/Case Ground               |
| 3    | Output                           |
| 4    | Supply Voltage                   |
| LINE | MARKING                          |
| 1    | E120.00<br>E=Ecliptek Designator |

#### Suggested Solder Pad Layout

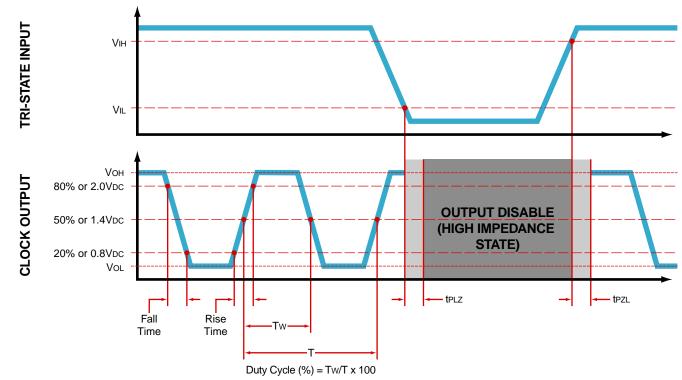
All Dimensions in Millimeters



All Tolerances are ±0.1



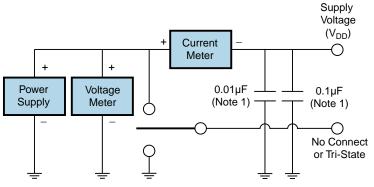
#### **OUTPUT WAVEFORM & TIMING DIAGRAM**

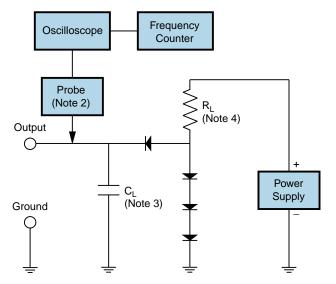


#### Test Circuit for TTL Output

| Output Load<br>Drive Capability | R <sub>L</sub> Value<br>(Ohms) | C <sub>L</sub> Value<br>(pF) |
|---------------------------------|--------------------------------|------------------------------|
| 10TTL                           | 390                            | 15                           |
| 5TTL                            | 780                            | 15                           |
| 2TTL                            | 1100                           | 6                            |
| 10LSTTL                         | 2000                           | 15                           |
| 1TTL                            | 2200                           | 3                            |







Note 1: An external 0.1µF low frequency tantalum bypass capacitor in parallel with a 0.01µF high frequency ceramic bypass capacitor close to the package ground and V<sub>DD</sub> pin is required.

Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth

(>300MHz) passive probe is recommended.

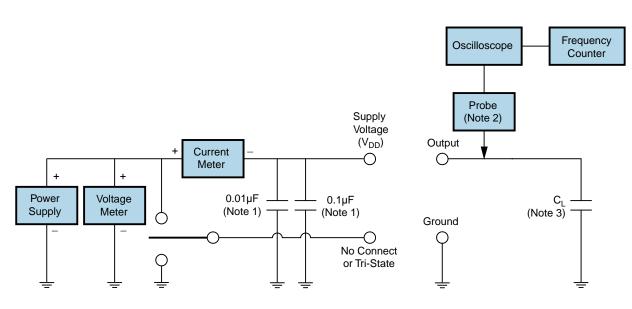
Note 3: Capacitance value  $C_{\text{L}}$  includes sum of all probe and fixture capacitance.

Note 4: Resistance value R<sub>L</sub> is shown in Table 1. See applicable specification sheet for 'Load Drive Capability'.

Note 5: All diodes are MMBD7000, MMBD914, or equivalent.



### **Test Circuit for CMOS Output**



Note 1: An external 0.1µF low frequency tantalum bypass capacitor in parallel with a 0.01µF high frequency ceramic bypass capacitor close to the package ground and V<sub>DD</sub> pin is required.

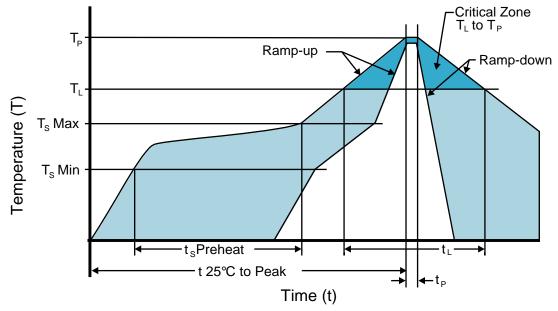
Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

Note 3: Capacitance value  $\dot{C}_1$  includes sum of all probe and fixture capacitance.



### **Recommended Solder Reflow Methods**

EH3525ETTTS-120.000M



### **High Temperature Infrared/Convection**

| T <sub>s</sub> MAX to T <sub>L</sub> (Ramp-up Rate) | 3°C/second Maximum                   |
|---|--------------------------------------|
| Preheat   |                                      |
| - Temperature Minimum (T <sub>s</sub> MIN)          | 150°C                                |
| - Temperature Typical (T <sub>s</sub> TYP)          | 175°C                                |
| - Temperature Maximum (T <sub>s</sub> MAX)          | 200°C                                |
| - Time (t <sub>s</sub> MIN)                         | 60 - 180 Seconds                     |
| Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )    | 3°C/second Maximum                   |
| Time Maintained Above:                              |                                      |
| - Temperature (T∟)                                  | 217°C                                |
| - Time (t <sub>L</sub> )                            | 60 - 150 Seconds                     |
| Peak Temperature (T <sub>P</sub> )                  | 260°C Maximum for 10 Seconds Maximum |
| Target Peak Temperature (T <sub>P</sub> Target)     | 250°C +0/-5°C                        |
| Time within 5°C of actual peak (t <sub>p</sub> )    | 20 - 40 seconds                      |
| Ramp-down Rate                                      | 6°C/second Maximum                   |
| Time 25°C to Peak Temperature (t)                   | 8 minutes Maximum                    |
| Moisture Sensitivity Level                          | Level 1                              |
|   |                                      |



### **Recommended Solder Reflow Methods**

EH3525ETTTS-120.000M



### Low Temperature Infrared/Convection 240°C

| T <sub>s</sub> MAX to T <sub>L</sub> (Ramp-up Rate) | mp-up Rate) 5°C/second Maximum                         |  |
|---|--|--|
| Preheat   |  |  |
| - Temperature Minimum (Ts MIN)                      | N/A  |  |
| - Temperature Typical (T <sub>s</sub> TYP)          | 150°C  |  |
| - Temperature Maximum (T <sub>s</sub> MAX)          | N/A  |  |
| - Time (t <sub>s</sub> MIN)                         | 60 - 120 Seconds                                       |  |
| Ramp-up Rate (T⊾ to T <sub>P</sub> )                | 5°C/second Maximum                                     |  |
| Time Maintained Above:                              |  |  |
| - Temperature (T∟)                                  | 150°C  |  |
| - Time (t∟)   | 200 Seconds Maximum                                    |  |
| Peak Temperature (T <sub>P</sub> )                  | 240°C Maximum  |  |
| Target Peak Temperature (T <sub>P</sub> Target)     | 240°C Maximum 1 Time / 230°C Maximum 2 Times           |  |
| Time within 5°C of actual peak (t <sub>p</sub> )    | 10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time |  |
| Ramp-down Rate                                      | 5°C/second Maximum                                     |  |
| Time 25°C to Peak Temperature (t)                   | N/A  |  |
| Moisture Sensitivity Level                          | Level 1  |  |

#### Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum.

#### **High Temperature Manual Soldering**

260°C Maximum for 5 seconds Maximum, 2 times Maximum.